

### Identification and Validation of Analytical Chemistry Methods for Detecting Composite Surface Contamination and Moisture

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## FAA Sponsored Project Information





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- FAA Technical Monitor
  - David Westlund, Curtis Davies
- Industry Participation
  - Exponent, Bombardier



## Introduction





- Motivation and Key Issues
  - Adhesive bonding is now used in manufacture and repair and is beginning to predominate over mechanical fastening.
  - Adherend surface preparation is a critical issue to the structural integrity and durability of bonded structures.
- Objective
  - benchmark knowledge of surface preparation quality assurance methods
  - Identify, evaluate, and validate definitive analytical chemistry methods to provide sufficient in-field quality assurance.
- Approach
  - Literature review and analysis (completed)
  - Surface chemistry analysis
  - Electrochemical sensor evaluation
  - Experimental validation
    - The Joint Advanced Materials and Structures Center of Excellence





## JMS

### Working principle of the All Solidstate Electrochemical Sensor



The electrons that are given off at the reactions between mediator and the functional groups and/or contaminants are compensated by a current through the Ag electrode. The amount of the electrons that are given off is reflected by the current passing through the electrode.

### 2<sup>nd</sup> Generation Solid-state Electrochemical Sensor-Experimental Setup

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- EIS was conducted on composite samples supplied by Bombardier.
- The composite samples' surface conditions were varied. Contaminants included:

Diestone HFP cleanser, UV dye, ultrasonic coupling gel, silicone glove residue, solution from marker, tape residue (no silicone, MTI RAE1000), soda, coffee and protective cream.



### JMS

## Electrical Impedance Spectroscopy Results





Sample	Polarization Impedance (ohm)
Pristine	2.0 x 10 <sup>6</sup>
Cleanser (Diestone HFP) residue	1.8 x 10 <sup>5</sup>
UV dye	6.0 x 10 <sup>5</sup>
Ultrasonic coupling gel	6.0 x 10 <sup>5</sup>
Silicone rubber glove residue	1.8 x 10 <sup>6</sup>
Solution from a marker	8.0 x 10 <sup>5</sup>
Tape Residue no silicone (MTI RAE1000)	1.7 x 10 <sup>6</sup>
Soda	6.5 x 10 <sup>5</sup>
Coffee	6.0 x 10 <sup>5</sup>
Protective cream	1.2 x 10 <sup>3</sup>

### JMS

### **SEM/EDAX Results**







Element Line	Weight %	Weight % Error
СК	92.38	+/- 1.49
ОК	3.41	+/- 1.03
ΑΙ Κ	4.21	+/- 0.35
S K	0	
S L		
КК	0	
KL		
Total	100.00	

Note: scan area is 0.3 cm<sup>2</sup>

Element Line	Weight %	Weight % Error
СК	70.52	+/- 1.21
ОК	21.15	+/- 1.36
Al K	4.36	+/- 0.29
S K	1.83	+/- 0.25
S L		
КК	2.15	+/- 0.21
KL		
Total	100.00	



Surface Contaminated with Ultrasonic Coupling Gel

**Pristine Surface** 



0.07

0.08

0.00

0.07

0.11

1.38

0.00

0.00

0.06

**P6** 

90.8

6.2

0.92

0.13

0.01

0.00

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### **EDAX/EIS Results**





Sample	[O], wt%	[Al], wt%	[K], wt%	[Si], wt%	[Na], wt%	[S], wt%	[Zn] Wt%	Polarization Impedance (ohm)
Pristine	3.41	4.21	0	0	0	0	0	2.0 x 10 <sup>6</sup>
Cleanser	18.63	4.51	0	0	0	1.63	0	1.8 x 10⁵
UV dye	17.19	4.03	0	0	0	2.55	0	6.0 x 10⁵
Ultrasonic coupling gel	21.15	4.36	2.15	0	0	1.83	0	6.0 x 10⁵
Silicone rubber glove residue	18.15	4.46	0	0	0	2.09	0	1.8 x 10 <sup>6</sup>
Solution from a marker	17.69	3.64	0	0	0	2.63	0	8.0 x 10 <sup>5</sup>
Tape Residue	16.02	4.55	0	0	0	2.85	0	1.7 x 10 <sup>6</sup>
Soda	25.12	3.77	0	0	0	1.07	0	6.5 x 10 <sup>5</sup>
Coffee	15.07	4.57	0	0.75	0	2.37	0	6.0 x 10 <sup>5</sup>
Protective cream	9.31	0.88	0	0.10	0.58	0	2.75	1.2 x 10 <sup>3</sup>





## JMS Results – Unmodified Probe vs. Epoxy Probe





#### **Results on Gold-Coated Silicon Wafers**







Unmodified surface - unmodified probe

Modified surface - unmodified probe Modified surface - Modified probe Modified surface is mixed with hydrophobic and hydrophilic domains

### **Results on Clean Mica Wafers**

Probe	Adhesion Force (nN)	SD
Ероху	65.36	1.85
Unmodified	2.66	0.194

	<sup></sup>	Temperature (C)	Tip No.	Mean of 50 adhesion force	S.D
	52.2	22.5	1	10.997	1.7966
	50.4	23.4	2	32.803	0.97307
Day 1	50.3	23.5	3	19.967	1.3857
	49.6	23.7	4	13.714	2.2984
	49.0	23.8	5	18.056	6.0413

**AFM – Environmental Effects** 

JMS

		Temperature (C)	Tip No.	Mean of 50 adhesion force	S.D
	56.7	22.2	1	17.036	1.1987
Day 2	55.2	22.5	2	7.7828	0.71156
	55.6	22.6	3	9.7174	1.1738
	54.7	22.6	4	6.0493	0.61482
	54.2	22.8	5	7.7124	0.8806

Trials were conducted with unmodified tips on a freshly cleaved mica wafer

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## JMS CFM Images and Adhesion Force Values







CFM contact mode: height and friction image of nylon peel-ply sample

Points	Mean Adhesion Force (nN)	SD
Α	0.772	0.01
В	0.215	0.013
С	0.023	0.015
D (background)	0.579	0.013



Curson: fixed 2 Zoom: 2:1 Cen line: Off Offset: Off

Sectional analysis of composite laminate

Force curves on nylon peel-ply sample

## JMS Force Volume – Unmodified Probe







Nylon prepared peel-ply sample surface



Polyester prepared peel-ply sample surface



#### Mean Adhesion Force

Nylon: 16.73 nN Polyester: 92.01 pN

Water contact angle Nylon ply: 75° Polyester ply: 130°

# JAMS Force Volume – Epoxy Probe







#### Nylon prepared peel-ply sample surface







Histogram shows two different regions of adhesion Indicating the epoxy probe is sensitive to surface contamination.

The adhesion values are higher for polyester when compared with nylon, demonstrating the hydrophobic (epoxy probe) and hydrophilic (nylon surface) nature of the materials.

Polyester prepared peel-ply sample surface



## Conclusions





- The all solid-state electrochemical sensor can differentiate the pristine and a variety of contaminated laminate surfaces. The simple designs, fabrication protocols, and testing setup allow implementation of an online and in-field technology for pre-bonding inspection of the laminate surface.
- EIS results show that a specific mediator or redox pair may be sensitive to certain compounds but insensitive to others. The sensitivity of other mediators or redox pairs needs to be examined.
- SEM/EDAX analyses confirm that the surface of the pristine sample has a simplest composition and hence may be used as a baseline for the EIS measurements. More analyses are needed to establish a correlation between surface chemistry and polarization impedance.
- The epoxy probe is shown to be more sensitive than the unmodified probe.
- As expected, humidity can dramatically influence the AFM adhesion force results.
- CFM can be used to discriminate between various function groups on composite surfaces prepared with nylon and polyester peel-plies.
- Force volume is a promising technique for systematically quantifying the surface activity using force spectroscopy.